

# SN54284, SN54285, SN74284, SN74285 4-BIT BY 4-BIT PARALLEL BINARY MULTIPLIERS

SDLS096

MAY 1972 - REVISED MARCH 1988

- Fast Multiplication of Two Binary Numbers  
8-Bit Product in 40 ns Typical
- Expandable for N-Bit-by-n-Bit Applications:  
16-Bit Product in 70 ns Typical  
32-Bit Product in 103 ns Typical
- Fully Compatible with Most TTL Circuits
- Diode-Clamped Inputs Simplify System Design

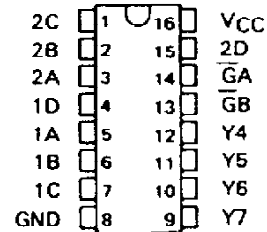
## description

These high-speed TTL circuits are designed to be used in high-performance parallel multiplication applications. When connected as shown in Figure A, these circuits perform the positive-logic multiplication of two 4-bit binary words. The eight-bit binary product is generated with typically only 40 nanoseconds delay.

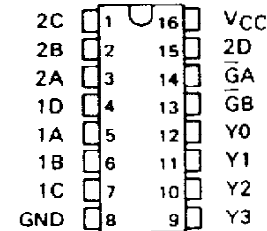
This basic four-by-four multiplier can be utilized as a fundamental building block for implementing larger multipliers. For example, the four-by-four building blocks can be connected as shown in Figure B to generate submultiple partial products. These results can then be summed in a Wallace tree, and, as illustrated, will produce a 16-bit product for the two eight-bit words typically in 70 nanoseconds. SN54H183/SN74H183 carry-save adders and SN54S181/SN74S181 arithmetic logic units with the SN54S182/SN74S182 look-ahead generator are used to achieve this high performance. The scheme is expandable for implementing N X M bit multipliers.

The SN54284 and SN54285 are characterized for operation over the full military temperature range of -55°C to 125°C; the SN74284 and SN74285 are characterized for operation from 0°C to 70°C.

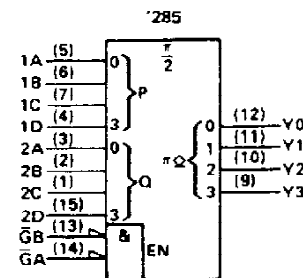
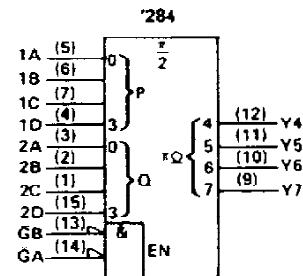
SN54284 . . . J OR W PACKAGE  
SN74284 . . . N PACKAGE  
(TOP VIEW)



SN54285 . . . J OR W PACKAGE  
SN74285 . . . N PACKAGE  
(TOP VIEW)



## logic symbols†



†These symbols are in accordance with ANSI/IEEE Std. 91-1984 and IEC Publication 617-12.

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## schematics

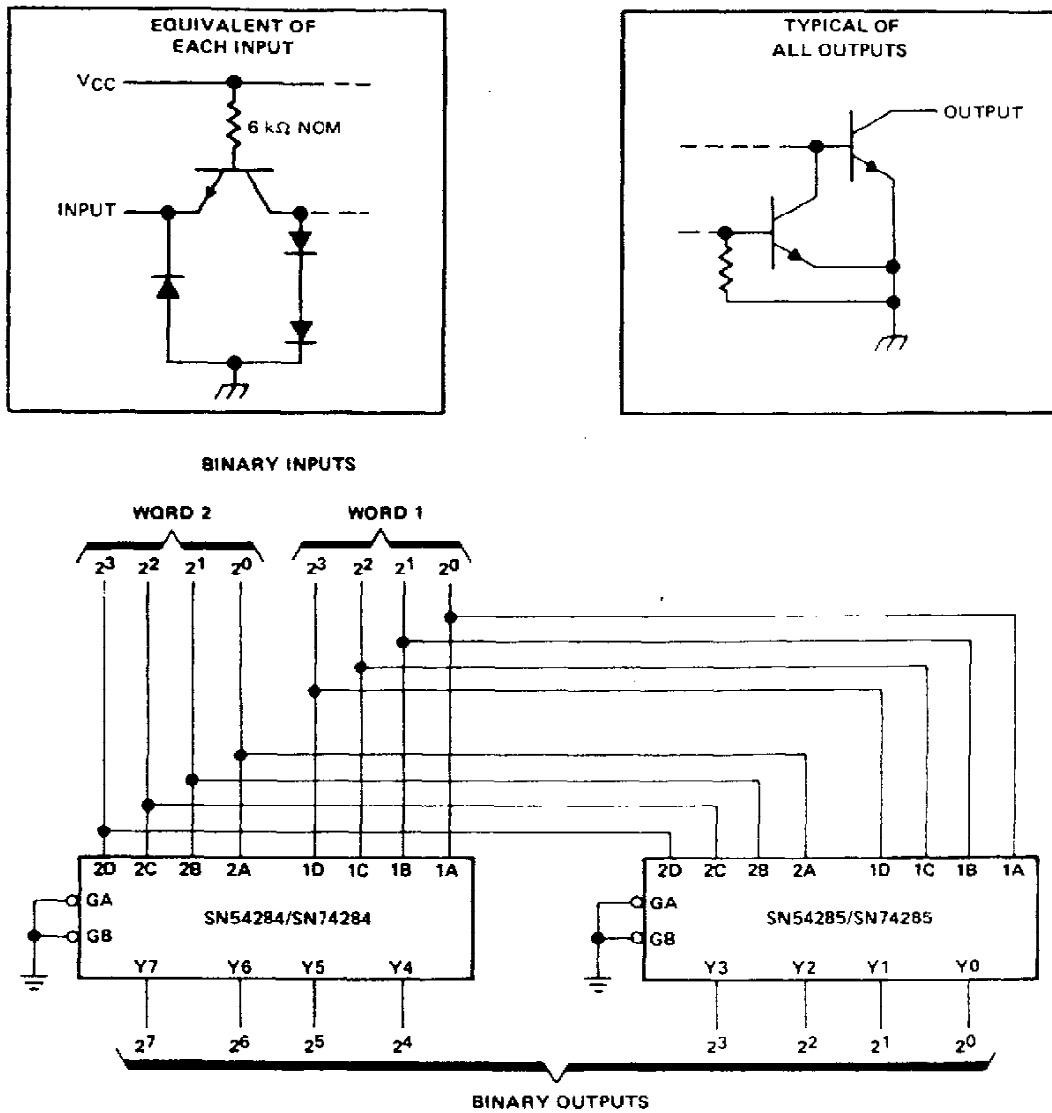
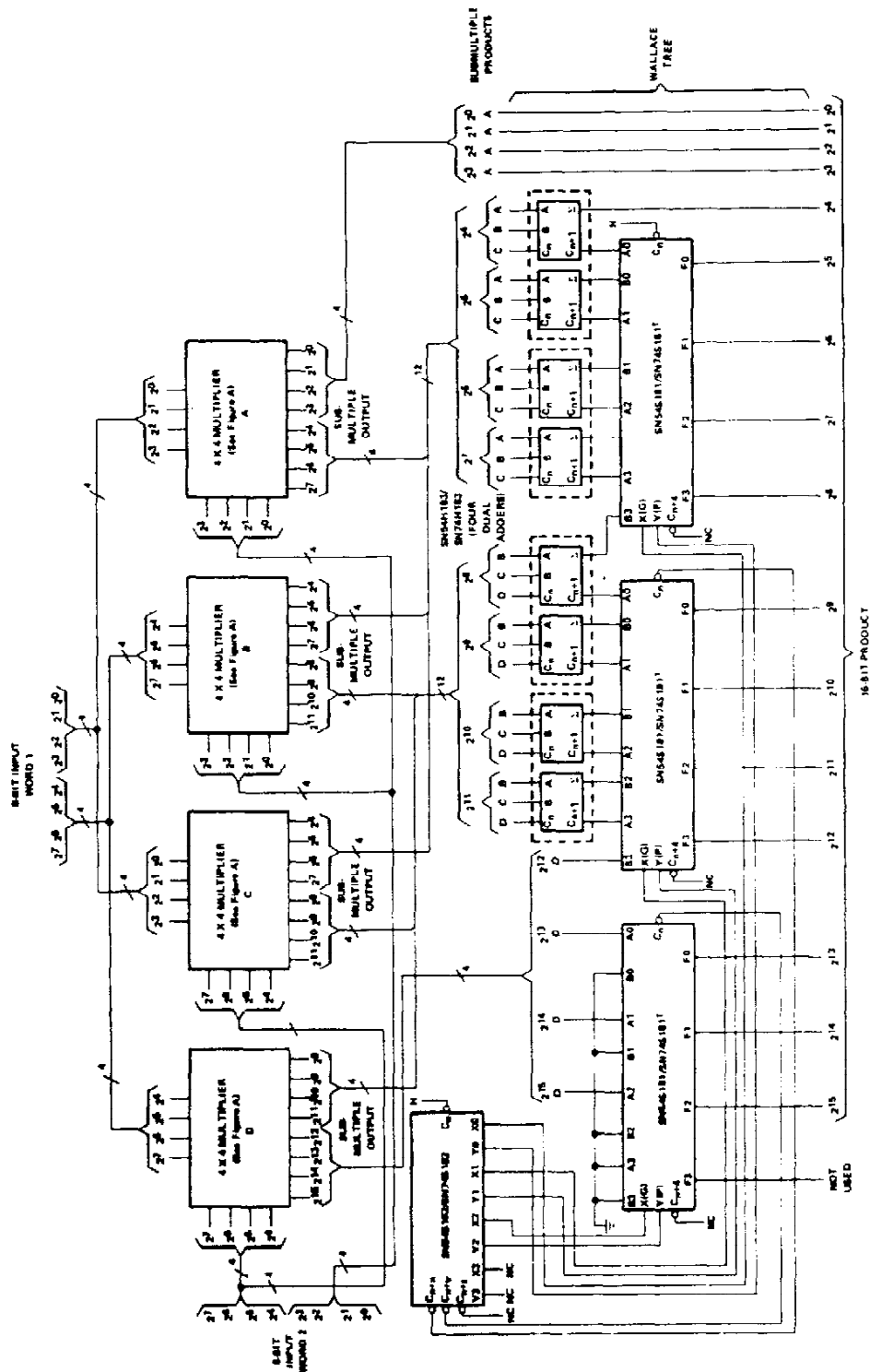


FIGURE A-4 X 4 MULTIPLIER

**SN54284, SN54285, SN74284, SN74285**  
**4-BIT BY 4-BIT PARALLEL BINARY MULTIPLIERS**



**FIGURE B-8 16-BIT BY 8-BIT MULTIPLIER**

\*Other terminals of the three SN54S181/SN74S181 ALU's are connected as follows: S3 = H, S2 = L, S1 = L, S0 = H, M = L, Output A = B is not used for this application.

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# **SN54284, SN54285, SN74284, SN74285** **4-BIT BY 4-BIT PARALLEL BINARY MULTIPLIERS**

absolute maximum ratings over operating free-air temperature range (unless otherwise noted)

|  |                |
|--|----------------|
| Supply voltage, $V_{CC}$ (see Note 1)                | 7 V            |
| Input voltage  | 5.5 V          |
| Operating free-air temperature range: SN54' Circuits | -55°C to 125°C |
| SN74' Circuits                                       | 0°C to 70°C    |
| Storage temperature range                            | -65°C to 150°C |

NOTE 1: Voltage values are with respect to network ground terminal.

recommended operating conditions

|                                       | SN54284<br>SN54285 |     |     | SN74284<br>SN74285 |     |      | UNIT |
|---------------------------------------|--------------------|-----|-----|--------------------|-----|------|------|
|                                       | MIN                | NOM | MAX | MIN                | NOM | MAX  |      |
| Supply voltage, $V_{CC}$              | 4.5                | 5   | 5.5 | 4.75               | 5   | 5.25 | V    |
| High-level output voltage, $V_{OH}$   |                    |     | 5.5 |                    |     | 5.5  | V    |
| Low-level output current, $I_{OL}$    |                    |     | 16  |                    |     | 16   | mA   |
| Operating free-air temperature, $T_A$ | -55                |     | 125 | 0                  |     | 70   | °C   |

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

| PARAMETER   | TEST CONDITIONS†  |                                      | MIN              | TYP‡ | MAX  | UNIT |     |
|---|---|--------------------------------------|------------------|------|------|------|-----|
| V <sub>IH</sub> High-level input voltage              |   |                                      |                  | 2    |      | V    |     |
| V <sub>IL</sub> Low-level input voltage               |   |                                      |                  |      | 0.8  | V    |     |
| V <sub>I</sub> Input clamp voltage                    | V <sub>CC</sub> = MIN, I <sub>I</sub> = -12 mA  |                                      |                  |      | -1.5 | V    |     |
| I <sub>OH</sub> High-level output current             | V <sub>CC</sub> = MIN, V <sub>IH</sub> = 2 V,<br>V <sub>IL</sub> = 0.8 V, V <sub>OH</sub> = 5.5 V |                                      |                  |      | 40   | µA   |     |
| V <sub>OL</sub> Low-level output voltage              | V <sub>CC</sub> = MIN,<br>V <sub>IH</sub> = 2 V,<br>V <sub>IL</sub> = 0.8 V                       | I <sub>OL</sub> = 12 mA              |                  |      | 0.4  | V    |     |
|   |   | I <sub>OL</sub> = 16 mA              |                  |      | 0.45 |      |     |
| I <sub>I</sub> Input current at maximum input voltage | V <sub>CC</sub> = MAX, V <sub>I</sub> = 5.5 V   |                                      |                  |      | 1    | mA   |     |
| I <sub>IH</sub> High-level input current              | V <sub>CC</sub> = MAX, V <sub>I</sub> = 2.4 V   |                                      |                  |      | 40   | µA   |     |
| I <sub>IL</sub> Low-level input current               | V <sub>CC</sub> = MAX, V <sub>I</sub> = 0.4 V   |                                      |                  |      | -1   | mA   |     |
| I <sub>CC</sub> Supply current                        | V <sub>CC</sub> = MAX,<br>T <sub>A</sub> = 125°C,<br>See Note 2                                   | SN54284, SN54285<br>N package only   |                  |      | 99   | mA   |     |
|   |   | V <sub>CC</sub> = MAX,<br>See Note 2 | SN54284, SN54285 |      | 92   |      | 110 |
|   |   | SN74284, SN74285                     |                  | 92   | 130  |      |     |

†For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions for the applicable device type.

‡All typical values are at  $V_{CC} = 5 \text{ V}, T_A = 25^\circ\text{C}$ .

NOTE 2: With outputs open and both enable inputs grounded,  $I_{CC}$  is measured first by selecting an output product which contains three or more high-level bits, then by selecting an output product which contains four low-level bits.

switching characteristics,  $V_{CC} = 5 \text{ V}, T_A = 25^\circ\text{C}$

| PARAMETER   | TEST CONDITIONS   | MIN | TYP | MAX | UNIT |
|---|---|-----|-----|-----|------|
| $t_{PLH}$ Propagation delay time, low-to-high-level output from enable      | $C_L = 30 \text{ pF}$ to GND,<br>$R_{L1} = 300 \Omega$ to $V_{CC}$ ,<br>$R_{L2} = 600 \Omega$ to GND,<br>See Note 3 | 20  | 30  |     | ns   |
| $t_{PHL}$ Propagation delay time, high-to-low-level output from enable      |   | 20  | 30  |     |      |
| $t_{PLH}$ Propagation delay time, low-to-high-level output from word inputs |   | 40  | 60  |     | ns   |
| $t_{PHL}$ Propagation delay time, high-to-low-level output from word inputs |   | 40  | 60  |     |      |

NOTE 3: Load circuits and voltage waveforms are shown in Section 1.

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